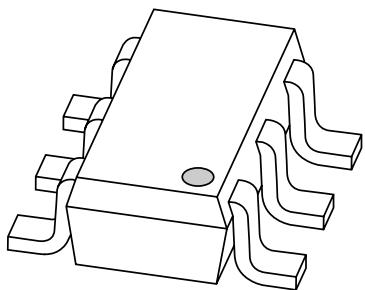


DATA SHEET



PBSS4240DPN
40 V low V_{CEsat} NPN/PNP
transistor

Product specification

2003 Feb 20

40 V low V_{CEsat} NPN/PNP transistor**PBSS4240DPN****FEATURES**

- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High collector current gain h_{FE} at high I_C
- High efficiency leading to reduced heat generation
- Reduced printed-circuit board area requirements.

APPLICATIONS

- Power management:
 - Complementary MOSFET driver
 - Dual supply line switching.
- Peripheral driver:
 - Half and full bridge motor drivers
 - Multi-phase stepper motor driver.

DESCRIPTION

NPN/PNP low V_{CEsat} transistor pair in a SOT457 (SC-74) plastic package.

MARKING

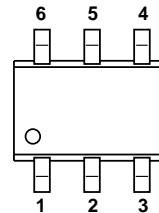
TYPE NUMBER	MARKING CODE
PBSS4240DPN	M3

QUICK REFERENCE DATA

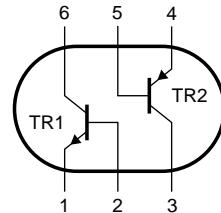
SYMBOL	PARAMETER	MAX.		UNIT
		NPN	PNP	
V_{CEO}	emitter-collector voltage	40	-40	V
I_C	collector current (DC)	1.35	-1.1	A
I_{CRP}	repetitive peak collector current	2	-2	A
I_{CM}	peak collector current	3	-3	A
R_{CEsat}	equivalent on-resistance	200	260	$m\Omega$

PINNING

PIN	DESCRIPTION	
1, 4	emitter	TR1; TR2
2, 5	base	TR1; TR2
6, 3	collector	TR1; TR2



Top view



MAM445

Fig.1 Simplified outline SOT457 (SC-74) and symbol.

40 V low V_{CEsat} NPN/PNP transistor

PBSS4240DPN

LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
Per transistor unless otherwise specified; for the PNP transistor with negative polarity					
V_{CBO}	collector-base voltage	open emitter	—	40	V
V_{CEO}	collector-emitter voltage	open base	—	40	V
V_{EBO}	emitter-base voltage	open collector	—	5	V
I_C	collector current (DC)		—		
	NPN		—	1.35	A
	PNP		—	-1.1	A
I_{CRP}	repetitive peak collector current	note 1	—	2	A
I_{CM}	peak collector current	single peak	—	3	A
I_B	base current (DC)		—	300	mA
I_{BM}	peak base current		—	1	A
P_{tot}	total power dissipation	$T_{amb} \leq 25^\circ\text{C}$; note 2	—	370	mW
		$T_{amb} \leq 25^\circ\text{C}$; note 3	—	310	mW
		$T_{amb} \leq 25^\circ\text{C}$; note 1	—	1.1	W
T_{stg}	storage temperature		-65	+150	°C
T_j	junction temperature		—	150	°C
T_{amb}	operating ambient temperature		-65	+150	°C
Per device					
P_{tot}	total power dissipation	$T_{amb} \leq 25^\circ\text{C}$; note 2	—	600	mW

Notes

1. Operated under pulsed conditions: duty cycle $\delta \leq 20\%$; pulse width $t_p \leq 10$ ms; mounting pad for collector standard footprint.
2. Device mounted on a printed-circuit board; single-sided copper; tinplated; mounting pad for collector 1 cm^2 .
3. Device mounted on a printed-circuit board; single-sided copper; tinplated; standard footprint.

THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
Per transistor				
$R_{th\ j-a}$	thermal resistance from junction to ambient	in free air; note 1	340	K/W
		in free air; note 2	110	K/W

Notes

1. Device mounted on a printed-circuit board, single-sided copper, tinplated, mounting pad for collector 1 cm^2 .
2. Operated under pulsed conditions: pulse width $t_p \leq 10$ ms; duty cycle $\delta \leq 0.20$; mounting pad for collector standard footprint.

40 V low V_{CEsat} NPN/PNP transistor

PBSS4240DPN

CHARACTERISTICS $T_{amb} = 25^\circ\text{C}$ unless otherwise specified.

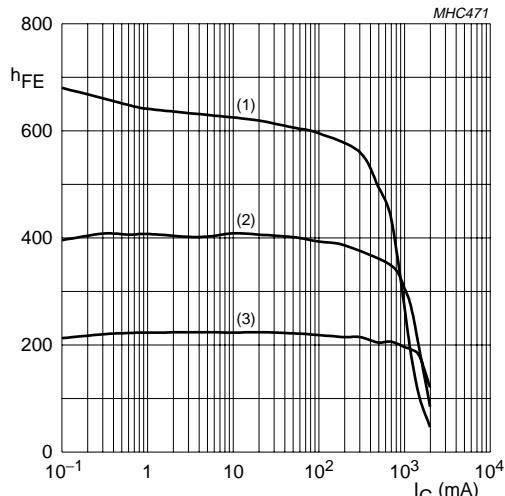
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Per transistor unless otherwise specified; for the PNP transistor with negative polarity						
I_{CBO}	collector-base cut-off current	$V_{CB} = 40\text{ V}; I_E = 0$	—	—	100	nA
		$V_{CB} = 40\text{ V}; I_E = 0; T_j = 150^\circ\text{C}$	—	—	50	μA
I_{CEO}	collector-emitter cut-off current	$V_{CE} = 30\text{ V}; I_B = 0$	—	—	100	nA
I_{EBO}	emitter-base cut-off current	$V_{EB} = 5\text{ V}; I_C = 0$	—	—	100	nA
h_{FE}	DC current gain	$V_{CE} = 5\text{ V}; I_C = 1\text{ mA}$	300	—	—	
f_T	transition frequency	$I_C = 50\text{ mA}; V_{CE} = 10\text{ V}; f = 100\text{ MHz}$	150	—	—	MHz
C_c	collector capacitance	$V_{CB} = 10\text{ V}; I_E = I_e = 0; f = 1\text{ MHz}$	—	—	12	pF
TR1 (NPN)						
h_{FE}	DC current gain	$V_{CE} = 5\text{ V}; I_C = 500\text{ mA}$	300	—	900	
		$V_{CE} = 5\text{ V}; I_C = 1\text{ A}$	200	—	—	
		$V_{CE} = 5\text{ V}; I_C = 2\text{ A}; \text{note 1}$	75	—	—	
V_{CEsat}	collector-emitter saturation voltage	$I_C = 100\text{ mA}; I_B = 1\text{ mA}$	—	60	75	mV
		$I_C = 500\text{ mA}; I_B = 50\text{ mA}$	—	80	100	mV
		$I_C = 1\text{ A}; I_B = 100\text{ mA}$	—	150	200	mV
		$I_C = 2\text{ A}; I_B = 200\text{ mA}; \text{note 1}$	—	300	400	mV
V_{BEsat}	base-emitter saturation voltage	$I_C = 1\text{ A}; I_B = 100\text{ mA}$	—	—	1.2	V
V_{BEon}	base-emitter turn-on voltage	$V_{CE} = 5\text{ V}; I_C = 1\text{ A}$	—	—	1.1	V
R_{CEsat}	equivalent on-resistance	$I_C = 1\text{ A}; I_B = 100\text{ mA}$	—	—	200	$\text{m}\Omega$
TR2 (PNP)						
h_{FE}	DC current gain	$V_{CE} = -5\text{ V}; I_C = -100\text{ mA}$	300	—	800	
		$V_{CE} = -5\text{ V}; I_C = -500\text{ mA}$	250	—	—	
		$V_{CE} = -5\text{ V}; I_C = -1\text{ A}$	160	—	—	
		$V_{CE} = -5\text{ V}; I_C = -2\text{ A}; \text{note 1}$	50	—	—	
V_{CEsat}	saturation voltage	$I_C = -100\text{ mA}; I_B = -1\text{ mA}$	—	-90	-120	mV
		$I_C = -500\text{ mA}; I_B = -50\text{ mA}$	—	-100	-145	mV
		$I_C = -1\text{ A}; I_B = -100\text{ mA}$	—	-180	-260	mV
		$I_C = -2\text{ A}; I_B = -200\text{ mA}; \text{note 1}$	—	-400	-530	mV
V_{BEsat}	saturation voltage	$I_C = -1\text{ A}; I_B = -50\text{ mA}$	—	—	-1.1	V
V_{BEon}	base-emitter turn-on voltage	$V_{CE} = -5\text{ V}; I_C = -1\text{ A}$	—	—	-1	V
R_{CEsat}	equivalent on-resistance	$I_C = -1\text{ A}; I_B = -100\text{ mA}; \text{note 1}$	—	—	260	$\text{m}\Omega$

Note

1. Pulse test: $t_p \leq 300\text{ }\mu\text{s}; \delta \leq 0.02$.

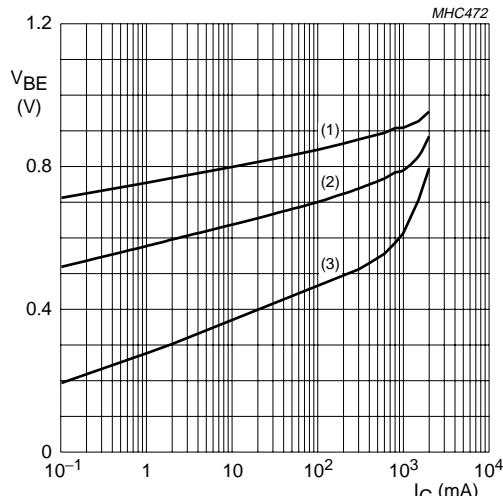
40 V low V_{CEsat} NPN/PNP transistor

PBSS4240DPN

TR1 (NPN); $V_{CE} = 5$ V.

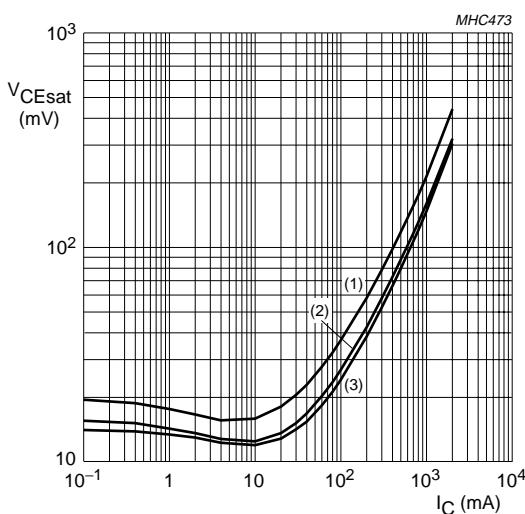
- (1) $T_{amb} = 150$ °C.
- (2) $T_{amb} = 25$ °C.
- (3) $T_{amb} = -55$ °C.

Fig.2 DC current gain as a function of collector current; typical values.

TR1 (NPN); $V_{CE} = 5$ V.

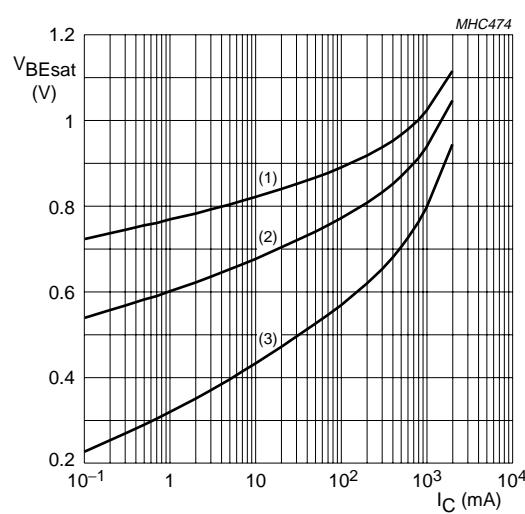
- (1) $T_{amb} = -55$ °C.
- (2) $T_{amb} = 25$ °C.
- (3) $T_{amb} = 150$ °C.

Fig.3 Base-emitter voltage as a function of collector current; typical values.

TR1 (NPN); $I_c/I_b = 20$.

- (1) $T_{amb} = 150$ °C.
- (2) $T_{amb} = 25$ °C.
- (3) $T_{amb} = -55$ °C.

Fig.4 Collector-emitter saturation voltage as a function of collector current; typical values.

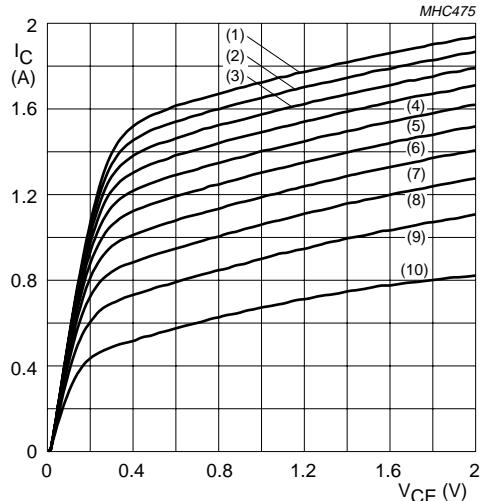
TR1 (NPN); $I_c/I_b = 20$.

- (1) $T_{amb} = -55$ °C.
- (2) $T_{amb} = 25$ °C.
- (3) $T_{amb} = 150$ °C.

Fig.5 Base-emitter saturation voltage as a function of collector current; typical values.

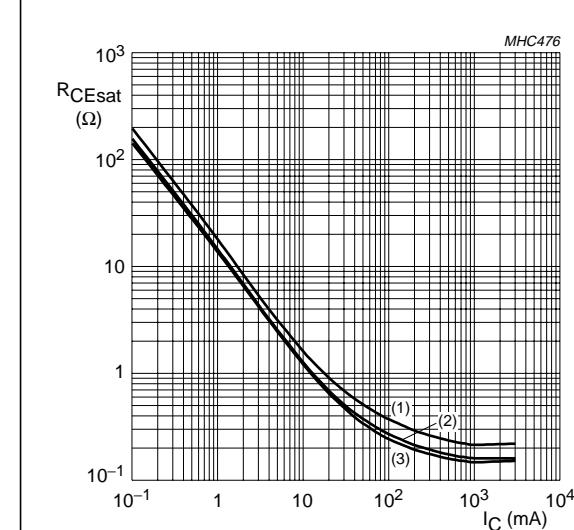
40 V low V_{CEsat} NPN/PNP transistor

PBSS4240DPN

**TR1 (NPN); $T_{amb} = 25\text{ }^{\circ}\text{C}$.**

- | | | |
|---------------------------|---------------------------|---------------------------|
| (1) $I_B = 30\text{ mA.}$ | (5) $I_B = 18\text{ mA.}$ | (9) $I_B = 6\text{ mA.}$ |
| (2) $I_B = 27\text{ mA.}$ | (6) $I_B = 15\text{ mA.}$ | (10) $I_B = 3\text{ mA.}$ |
| (3) $I_B = 24\text{ mA.}$ | (7) $I_B = 12\text{ mA.}$ | |
| (4) $I_B = 21\text{ mA.}$ | (8) $I_B = 9\text{ mA.}$ | |

Fig.6 Collector current as a function of collector-emitter voltage; typical values.

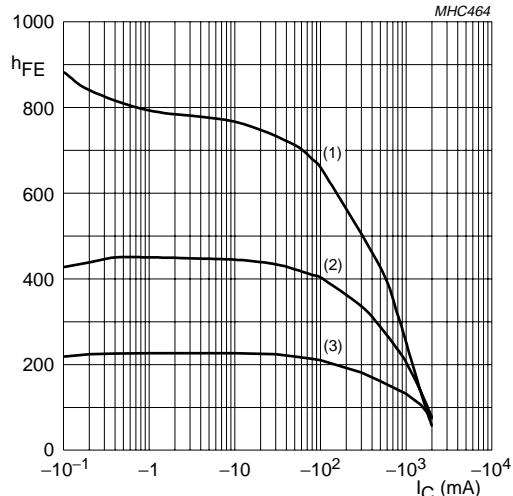
**TR1 (NPN); $I_c/I_B = 20$.**

- | |
|--|
| (1) $T_{amb} = 150\text{ }^{\circ}\text{C.}$ |
| (2) $T_{amb} = 25\text{ }^{\circ}\text{C.}$ |
| (3) $T_{amb} = -55\text{ }^{\circ}\text{C.}$ |

Fig.7 Collector-emitter equivalent on-resistance as a function of collector current; typical values.

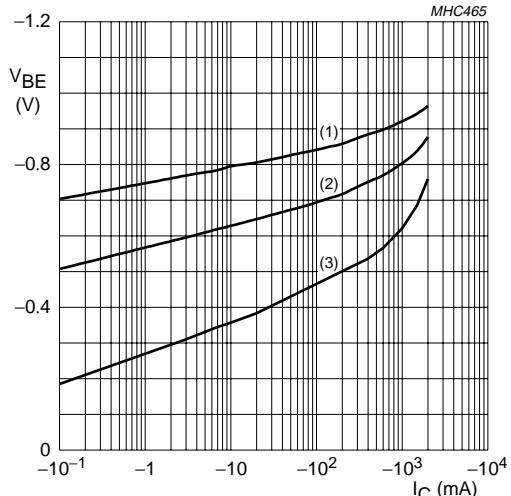
40 V low V_{CEsat} NPN/PNP transistor

PBSS4240DPN

**TR2 (PNP); $V_{CE} = -5$ V.**

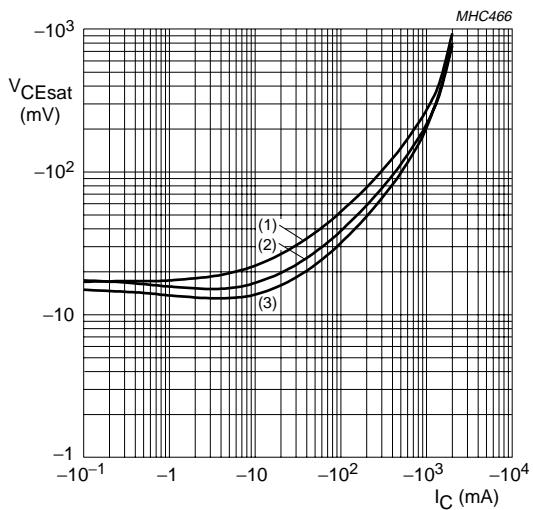
- (1) $T_{amb} = 150$ °C.
- (2) $T_{amb} = 25$ °C.
- (3) $T_{amb} = -55$ °C.

Fig.8 DC current gain as a function of collector current; typical values.

**TR2 (PNP); $V_{CE} = -5$ V.**

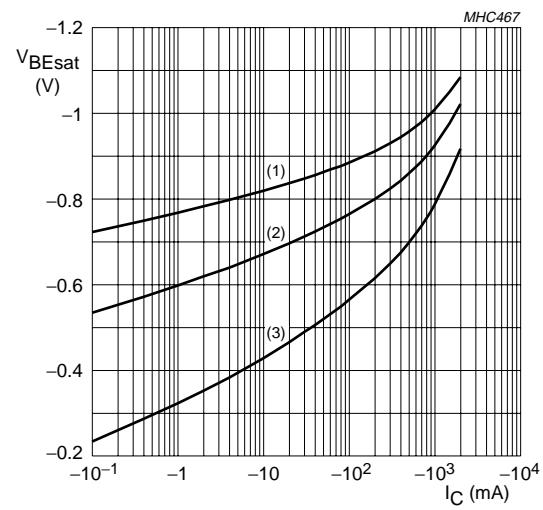
- (1) $T_{amb} = -55$ °C.
- (2) $T_{amb} = 25$ °C.
- (3) $T_{amb} = 150$ °C.

Fig.9 Base-emitter voltage as a function of collector current; typical values.

**TR2 (PNP); $I_C/I_B = 20$.**

- (1) $T_{amb} = 150$ °C.
- (2) $T_{amb} = 25$ °C.
- (3) $T_{amb} = -55$ °C.

Fig.10 Collector-emitter saturation voltage as a function of collector current; typical values.

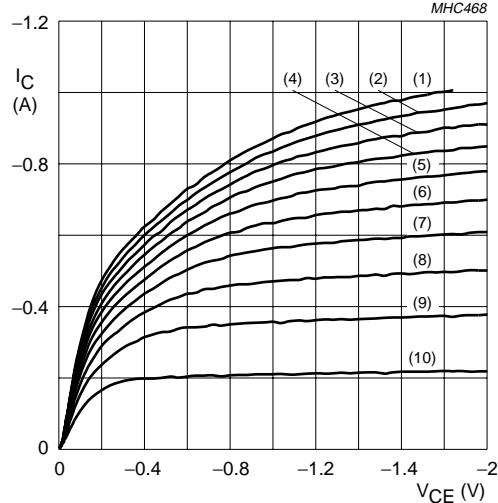
**TR2 (PNP); $I_C/I_B = 20$.**

- (1) $T_{amb} = -55$ °C.
- (2) $T_{amb} = 25$ °C.
- (3) $T_{amb} = 150$ °C.

Fig.11 Base-emitter saturation voltage as a function of collector current; typical values.

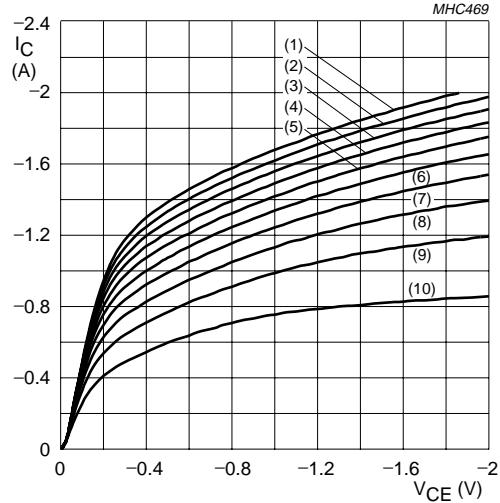
40 V low V_{CEsat} NPN/PNP transistor

PBSS4240DPN

TR2 (PNP); $T_{amb} = 25$ °C.

- (1) $I_B = -7$ mA. (5) $I_B = -4.2$ mA. (9) $I_B = -1.4$ mA.
- (2) $I_B = -6.3$ mA. (6) $I_B = -3.5$ mA. (10) $I_B = -0.7$ mA.
- (3) $I_B = -5.6$ mA. (7) $I_B = -2.8$ mA.
- (4) $I_B = -4.9$ mA. (8) $I_B = -2.1$ mA.

Fig.12 Collector current as a function of collector-emitter voltage; typical values.

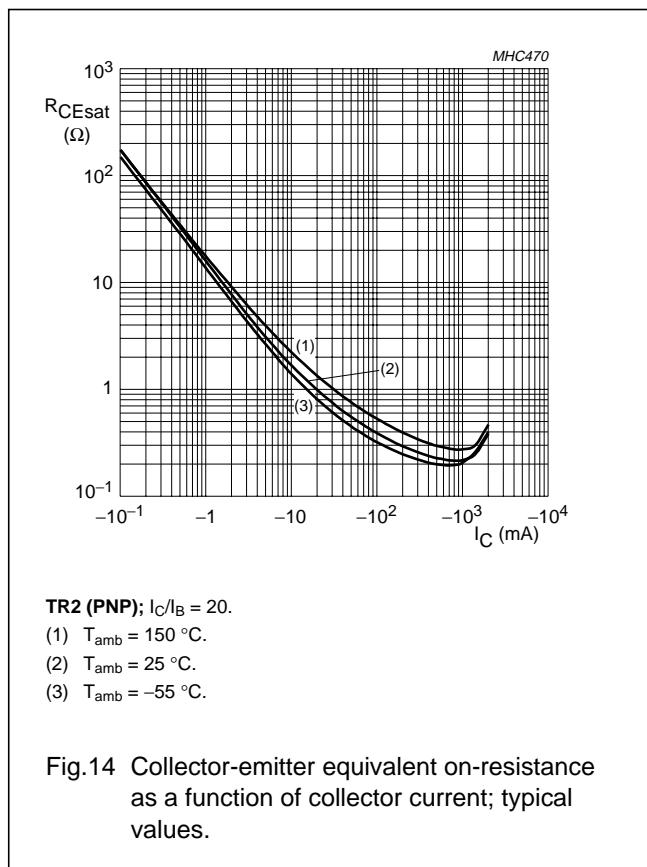
TR2 (PNP); $T_{amb} = 25$ °C.

- (1) $I_B = -50$ mA. (5) $I_B = -30$ mA. (9) $I_B = -10$ mA.
- (2) $I_B = -45$ mA. (6) $I_B = -25$ mA. (10) $I_B = -5$ mA.
- (3) $I_B = -40$ mA. (7) $I_B = -20$ mA.
- (4) $I_B = -35$ mA. (8) $I_B = -15$ mA.

Fig.13 Collector current as a function of collector-emitter voltage; typical values.

40 V low V_{CEsat} NPN/PNP transistor

PBSS4240DPN



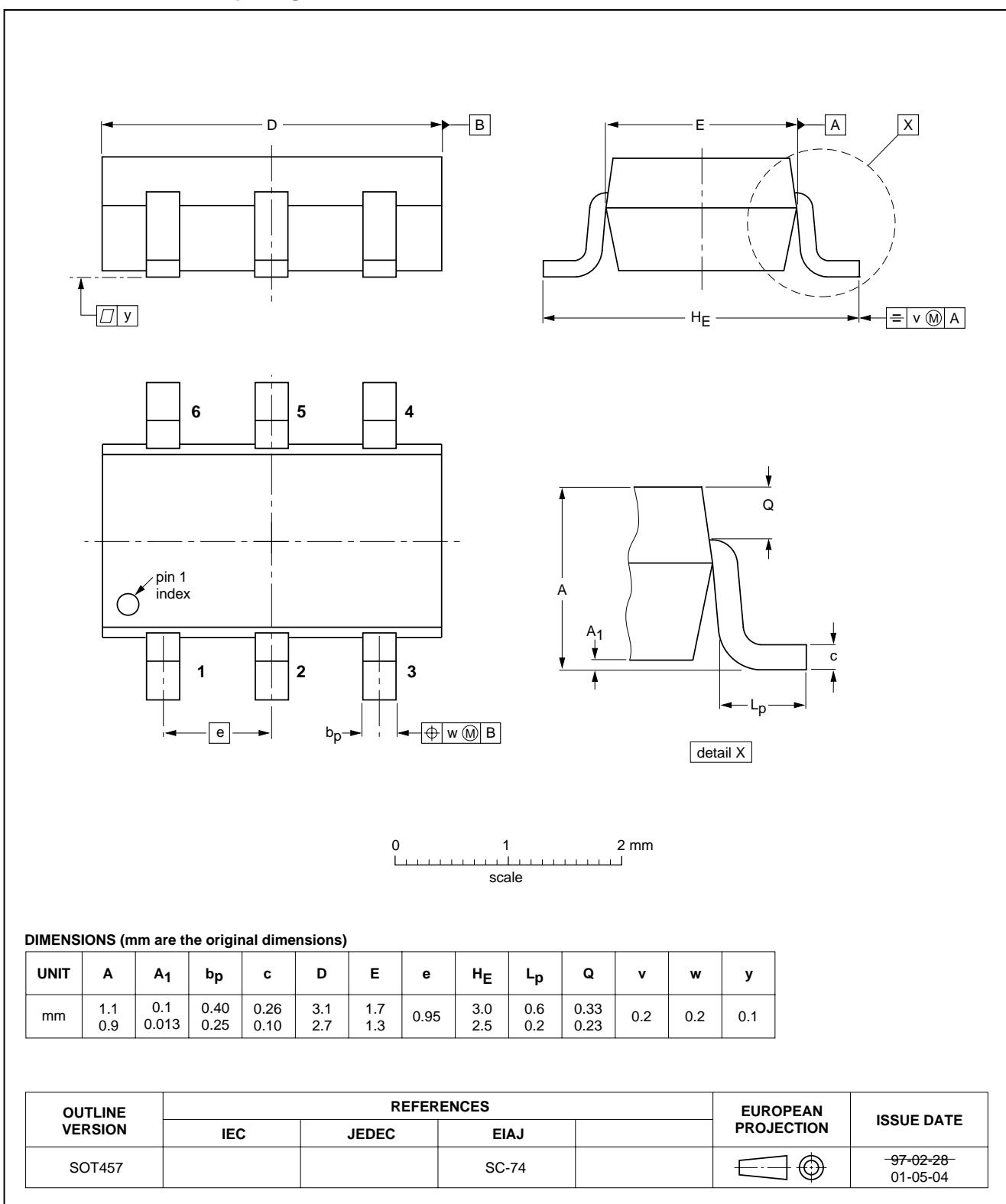
40 V low V_{CEsat} NPN/PNP transistor

PBSS4240DPN

PACKAGE OUTLINE

Plastic surface mounted package; 6 leads

SOT457



DIMENSIONS (mm are the original dimensions)

UNIT	A	A_1	b_p	c	D	E	e	H_E	L_p	Q	v	w	y
mm	1.1 0.9	0.013	0.25	0.26 0.10	3.1 2.7	1.7 1.3	0.95	3.0 2.5	0.6 0.2	0.33 0.23	0.2	0.2	0.1

OUTLINE VERSION	REFERENCES				EUROPEAN PROJECTION	ISSUE DATE
	IEC	JEDEC	EIAJ	SC-74		
SOT457						97-02-28 01-05-04

40 V low V_{CEsat} NPN/PNP transistor

PBSS4240DPN

DATA SHEET STATUS

LEVEL	DATA SHEET STATUS ⁽¹⁾	PRODUCT STATUS ⁽²⁾⁽³⁾	DEFINITION
I	Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.
II	Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.
III	Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN).

Notes

1. Please consult the most recently issued data sheet before initiating or completing a design.
2. The product status of the device(s) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL <http://www.semiconductors.philips.com>.
3. For data sheets describing multiple type numbers, the highest-level product status determines the data sheet status.

DEFINITIONS

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information — Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors make no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

DISCLAIMERS

Life support applications — These products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips Semiconductors customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips Semiconductors for any damages resulting from such application.

Right to make changes — Philips Semiconductors reserves the right to make changes in the products - including circuits, standard cells, and/or software - described or contained herein in order to improve design and/or performance. When the product is in full production (status 'Production'), relevant changes will be communicated via a Customer Product/Process Change Notification (CPCN). Philips Semiconductors assumes no responsibility or liability for the use of any of these products, conveys no licence or title under any patent, copyright, or mask work right to these products, and makes no representations or warranties that these products are free from patent, copyright, or mask work right infringement, unless otherwise specified.

Philips Semiconductors – a worldwide company

Contact information

For additional information please visit <http://www.semiconductors.philips.com>. Fax: +31 40 27 24825
For sales offices addresses send e-mail to: sales.addresses@www.semiconductors.philips.com.

© Koninklijke Philips Electronics N.V. 2003

SCA75

All rights are reserved. Reproduction in whole or in part is prohibited without the prior written consent of the copyright owner.

The information presented in this document does not form part of any quotation or contract, is believed to be accurate and reliable and may be changed without notice. No liability will be accepted by the publisher for any consequence of its use. Publication thereof does not convey nor imply any license under patent- or other industrial or intellectual property rights.

Printed in The Netherlands

613514/01/pp12

Date of release: 2003 Feb 20

Document order number: 9397 750 10783

Let's make things better.

**Philips
Semiconductors**



PHILIPS